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## AMENDMENTS TO THE CLAIMS

- 1. (Currently amended) A magnetron sputtering apparatus comprising:
  - a vacuum chamber;
  - a target;
  - a cathode holding the target in the vacuum chamber;
  - a substrate;
- an anode holding the substrate and being allocated located above the cathode so as to face the substrate toward the target on the cathode;
- a permanent magnet assembly generating a magnetic field and being allocated located under the cathode; and
- a rotation controller rotating the permanent magnet assembly around an axis so as to pivet with rotation occurring on almost a center of the target as the axis,

the permanent magnet assembly further comprising:

- a base;
- a first permanent magnet being fixed on the base in the middle; and
- a second permanent magnet in a ring shape being fixed in a peripheral area of the base so as to surround the first permanent magnet,
- wherein a magnetic polarity of the second permanent magnet is inverse with respect to a magnetic polarity of the first permanent magnet, and
- wherein magnetic field strength of the second permanent magnet is weaker than magnetic field strength of the first permanent magnet, and
- wherein the permanent magnet assembly is formed such that a plane constituted by a top surface of the first permanent magnet and another top surface of the second permanent magnet is slanted with respect to a surface of the target-in a cylindrical shape of which top portion is cut diagonally,

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- the magnetron sputtering apparatus is characterized in that the permanent magnet is perpendicularly allocated on a top-of the axis of rotation of the rotation controller.
- 2. (Currently amended) The magnetron sputtering apparatus in accordance with claim 1, wherein the first permanent magnet is fixed on a middle of the base in the middle with shifting wherein a center axis of the first permanent magnet is shifted eccentrically with respect to a the center of rotation of the permanent magnet assembly, and wherein the permanent magnet is either in a cylindrical shape of which top portion is cut diagonally or in a shape having different heights of which height steps down gradually from one end to the other.
- 3. (Currently amended) The A magnetron sputtering apparatus in accordance with claim 1, comprising:

  a vacuum chamber:

  a target;

  a cathode holding the target in the vacuum chamber;

  a substrate;

  an anode holding the substrate and being located above the cathode so as to face the substrate toward the target on the cathode;

  a permanent magnet assembly generating magnetic field and being located under the cathode; and

  a rotation controller rotating the permanent magnet assembly around an axis with rotation occurring on a center of the target as the axis, the permanent magnet assembly further comprising:

  a base;

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a first permanent magnet being fixed on a middle of the base in the middle with shifting wherein a center axis of the first permanent magnet is shifted eccentrically with respect to a-the center of rotation of the permanent magnet assembly; and

a second permanent magnet in a ring shape being fixed in a peripheral area of the base so as to surround the first permanent magnet[[,]]:

wherein a magnetic polarity of the second permanent magnet is inverse with respect to a magnetic polarity of the first permanent magnet[[,]]; and

wherein magnetic field strength of the second permanent magnet is weaker than magnetic field strength of the first permanent magnet, and

- wherein top surfaces of the first and second permanent magnets are made to be flat horizontally and in parallel with the base respectively.
- 4. (Currently amended) The magnetron sputtering apparatus in accordance with claim 1, further comprising:
- a wedge shaped member having a predetermined slant angle being located between the rotation controller and the permanent magnet assembly; and
- wherein a top surface of the member contacting a bottom surface of the base is slanted with respect to the target

wherein the permanent magnet is shaped into that top surfaces of the first and second permanent magnets are made to be flat horizontally and in parallel with the base respectively,

the magnetron sputtering apparatus is characterized in that the permanent magnet is allocated on a top of the axis of rotation of the rotation controller on a slant with respect to the axis of rotation of the rotation controller.

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- 5. (Currently amended) The magnetron sputtering apparatus in accordance with claim-1 2, further comprising:
- a wedge shaped member having a predetermined slant angle being located between the rotation controller and the permanent magnet assembly; and
- wherein a top surface of the member contacting a bottom surface of the base is slanted with respect to the target

wherein the first permanent magnet is fixed on the base in the middle with shifting a center axis of the first permanent magnet eccentrically with respect to a center of rotation of the permanent magnet; and

- wherein the permanent magnet is shaped into that top surfaces of the first and second permanent magnets are made to be flat horizontally and in parallel with the base respectively,
- —the magnetron sputtering apparatus is characterized in that the permanent magnet is allocated on a top of the axis of rotation of the rotation controller on a slant with respect to the axis of rotation of the rotation controller.
- 6. (Currently amended) A magnetron sputtering apparatus comprising:
  - a vacuum chamber:
  - a target;
  - a cathode holding the target in the vacuum chamber;
  - a substrate:
- an anode holding the substrate and being allocated above the cathode so as to face the substrate toward the target on the cathode; and
- a permanent magnet assembly generating magnetic field and being allocated located under the cathode[[,]];

the permanent magnet assembly further comprising:

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a first permanent magnet provided with a sliding mechanism for sliding the first permanent magnet horizontally with respect to the target, being allocated in the middle of the target base; and

a second permanent magnet being fixed in a peripheral area of the target base;[[,]] wherein a magnetic polarity the N-pole of the second first permanent magnet is inverse with respect to a magnetic polarity faces toward the target and the S-pole of the first second permanent magnet faces toward the target;[[,]] and

wherein magnetic field strength of the second permanent magnet is weaker than magnetic field strength of the first permanent magnet, and

wherein a top surface of the second permanent magnet is in parallel with a top surface of the first permanent magnet.